

#9  
D. B. J.  
4/16/02

**BOX AF**  
**REPLY UNDER 37 C.F.R. § 1.116**  
**EXPEDITED PROCEDURE**  
**EXAMINING GROUP 2855**



PATENT  
2927-013P

RECEIVED  
APR 11 2002

IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicants:	Noritoshi NAKAGAWA et al.	Conf:	8419
Serial No.:	09/607,324	Group:	2855
Filed:	June 30, 2000	Examiner:	A. Allen
For:	VISCOELASTIC CHARACTERISTIC VALUE-MEASURING APPARATUS AND METHOD OF MEASURING VISCOELASTIC CHARACTERISTIC VALUE		

REQUEST FOR INTERVIEW

**BOX AF**

Assistant Commissioner for Patents  
Washington, D.C. 20231

April 8, 2002

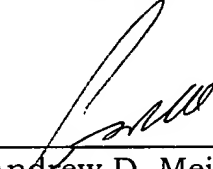
Sir:

Pursuant to the provisions of M.P.E.P. § 713.09, Applicant requests an interview with the Examiner prior to the Examiner issuing an Office Action, this interview being useful for expediting prosecution of the above-identified application. Upon scheduling the interview, Applicant will provide a written description of the points to be discussed in the interview.

The Examiner is requested to contact **Jayne Saydah (Reg. No. 48,796)** at (703) 205-8000 prior to issuing an Office Action, in order to arrange the interview.

Respectfully submitted,

BIRCH, STEWART, KOLASCH & BIRCH, LLP

By:   
Andrew D. Meikle  
Reg. No. 32,868

ADM/<sup>JK</sup>JES:sld  
(703) 205-8000

P.O. Box 747  
Falls Church, VA 22040-0747